

Silicon Carbide (SiC) **MOSFET** - EliteSiC, 40 mohm, 1200 V, M3S, TO-247-4L NTH4L040N120M3S

Features

- Typ. $R_{DS(on)} = 40 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge $(Q_{G(tot)} = 75 \text{ nC})$
- High Speed Switching with Low Capacitance (Coss = 80 pF)
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb-Free 2LI (on second level interconnection)

Typical Applications

- Solar Inverters
- Electric Vehicle Charging Stations
- UPS (Uninterruptible Power Supplies)
- Energy Storage Systems
- SMPS (Switch Mode Power Supplies)

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Parameter | | | Symbol | Value | Unit |
|--|--------------------------------------|-----------------------|-----------------------------------|----------------|------|
| Drain-to-Source Voltage | | | V_{DSS} | 1200 | V |
| Gate-to-Source Voltage | | | V_{GS} | -10/+22 | V |
| Continuous Drain Current (Notes 1, 3) | Steady T _C =25°C State | | I _D | 54 | Α |
| Power Dissipation (Note 1) | | | P _D | 231 | W |
| Continuous Drain Current (Notes 1, 3) | Steady State | T _C =100°C | I _D | 38 | Α |
| Power Dissipation (Note 1) | | | P _D | 115 | W |
| Pulsed Drain Current (Note 2) | T _C = 25°C | | I _{DM} | 134 | Α |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +175 | °C |
| Source Current (Body Diode) T _C = 25°C, V _{GS} = -3 V | | | Is | 45 | Α |
| Single Pulse Drain-to-Source Avalanche Energy (Note 4) | | | E _{AS} | 143 | mJ |
| Maximum Lead Temperature for Soldering (1/25" from case for 10 s) | | | TL | 270 | °C |

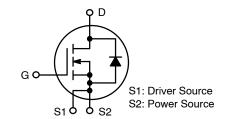
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

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- 2. Repetitive rating, limited by max junction temperature.
- 3. The maximium current rating is based on typical $R_{DS(on)}$ performance. 4. EAS of 143 mJ is based on starting $T_J = 25^{\circ}C$; L = 1 mH, $I_{AS} = 16.9$ A, $V_{DD} = 100 \text{ V}, V_{GS} = 18 \text{ V}.$

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 1200 V | 54 mΩ @ 18 V | 54 A |

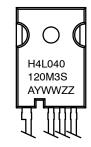


N-CHANNEL MOSFET



TO-247-4L CASE 340CJ

MARKING DIAGRAM



H4L040120M3S = Specific Device Code

= Assembly Location

= Year WW = Work Week = Lot Traceability

ORDERING INFORMATION

| Device | Package | Shipping |
|-----------------|-----------|--------------------|
| NTH4L040N120M3S | TO-247-4L | 30 Units / Tube |

Table 1. THERMAL CHARACTERISTICS

| Parameter | | Max | Unit |
|---|----------------|------|------|
| Junction-to-Case - Steady State (Note 1) | $R_{	heta JC}$ | 0.65 | °C/W |
| Junction-to-Ambient - Steady State (Note 1) | | 40 | |

Table 2. RECOMMENDED OPERATING CONDITIONS

| Parameter | Symbol | Value | Unit |
|--|------------|-------------|------|
| Operation Values of Gate-to-Source Voltage | V_{GSop} | −5−3 +18 | V |

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

| Parameter | Symbol | Test Condi | tion | Min | Тур | Max | Unit |
|--|--------------------------------------|---|--|------|------|-----|------|
| OFF-STATE CHARACTERISTICS | | I. | | | | ı | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} = 0 V, I _D = 1 mA | | 1200 | - | _ | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | I _D = 1 mA, reference (Note 6) | | - | 0.3 | - | V/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, V _{DS} = 1200 V | V _{GS} = 0 V, V _{DS} = 1200 V | | - | 100 | μΑ |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{GS} = +22/-10 \text{ V},$ | V _{DS} = 0 V | - | - | ±1 | μΑ |
| ON-STATE CHARACTERISTICS (Note: | 2) | | | • | • | • | • |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = 10 mA | 2.04 | 2.9 | 4.4 | V |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 18 V, I _D = 20 | A, T _J = 25°C | - | 40 | 54 | mΩ |
| | | V _{GS} = 18 V, I _D = 20 A, T _J = 175°C (Note 6) | | - | 80 | - | |
| Forward Transconductance | 9 _{FS} | V _{DS} = 10 V, I _D = 20 A (Note 6) | | - | 16 | _ | S |
| CHARGES, CAPACITANCES & GATE R | ESISTANCE | | | • | • | • | |
| Input Capacitance | C _{ISS} | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 800 V (Note 6) | | - | 1700 | _ | pF |
| Output Capacitance | C _{OSS} | | | - | 80 | - | 1 |
| Reverse Transfer Capacitance | C _{RSS} | | | - | 7 | - | |
| Total Gate Charge | Q _{G(TOT)} | $V_{GS} = -3/18 \text{ V}, V_{DS} = 800 \text{ V},$ | | - | 75 | - | nC |
| Threshold Gate Charge | Q _{G(TH)} | I _D = 20 A (No | ote 6) | - | 4.4 | - | |
| Gate-to-Source Charge | Q _{GS} | 1 | | - | 14 | - | |
| Gate-to-Drain Charge | Q_{GD} | | | - | 22 | - | |
| Gate-Resistance | R _G | f = 1 MH | Z | - | 3.8 | - | Ω |
| SWITCHING CHARACTERISTICS | | | | | | | |
| Turn-On Delay Time | t _{d(ON)} | $V_{GS} = -3/18 \text{ V}, V_{D}$ | os = 800 V, | - | 12 | _ | ns |
| Rise Time | t _r | I _D = 20 A, R _G = 4.7 Ω Inductive load (Notes 5, 6) | | - | 15 | - |] |
| Turn-Off Delay Time | t _{d(OFF)} | | | - | 35 | - | 1 |
| Fall Time | t _f | | | - | 10 | - |] |
| Turn-On Switching Loss | E _{ON} | | | - | 182 | - | μJ |
| Turn-Off Switching Loss | E _{OFF} | | | - | 66 | _ | 1 |
| Total Switching Loss | E _{tot} | | | _ | 248 | _ | 1 |

Table 3. ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|------------------|--|-----|------|-----|------|
| SOURCE-DRAIN DIODE CHARACTERIST | ics | • | | | • | |
| Continuous Source-Drain Diode Forward Current | I _{SD} | $V_{GS} = -3 \text{ V}, T_{C} = 25^{\circ}\text{C (Note 6)}$ | _ | - | 45 | А |
| Pulsed Source-Drain Diode Forward Current (Note 2) | I _{SDM} | | _ | - | 134 | |
| Forward Diode Voltage | V _{SD} | $V_{GS} = -3 \text{ V}, I_{SD} = 20 \text{ A}, T_{J} = 25^{\circ}\text{C}$ | - | 4.5 | _ | V |
| Reverse Recovery Time | t _{RR} | $V_{GS} = -3/18 \text{ V}, I_{SD} = 20 \text{ A},$ | - | 16.8 | - | ns |
| Reverse Recovery Charge | Q _{RR} | dI _S /dt = 1000 A/μs, V _{DS} = 800 V (Note 6) | - | 82 | - | nC |
| Reverse Recovery Energy | E _{REC} | | - | 44 | - | μJ |
| Peak Reverse Recovery Current | I _{RRM} | | - | 9.8 | - | Α |
| Charge Time | T _A | | - | 9.6 | - | ns |
| Discharge Time | T _B | 7 | _ | 7.2 | - | ns |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. E_{ON}/E_{OFF} result is with body diode.

6. Defined by design, not subject to production test.

TYPICAL CHARACTERISTICS

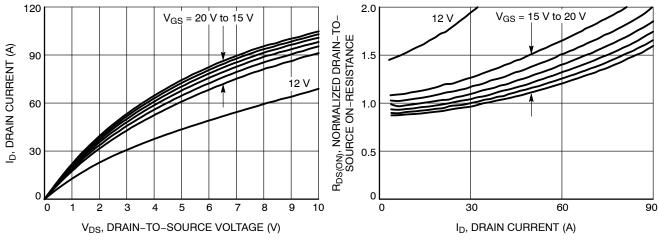


Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

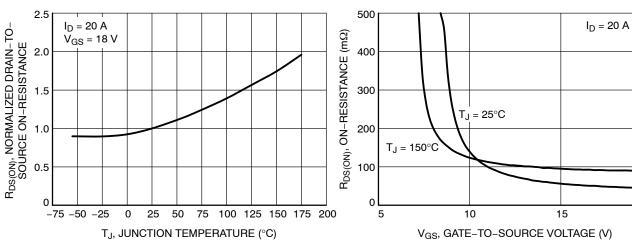


Figure 3. On–Resistance Variation with Temperature

Figure 4. On-Resistance vs. Gate-to-Source Voltage

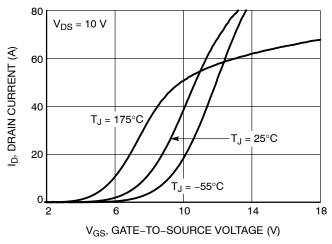


Figure 5. Transfer Characteristics

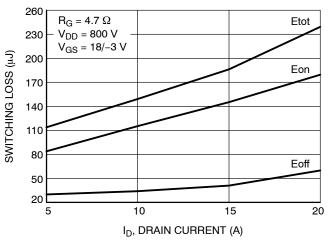


Figure 6. Switching Loss vs. Drain Current

20

TYPICAL CHARACTERISTICS

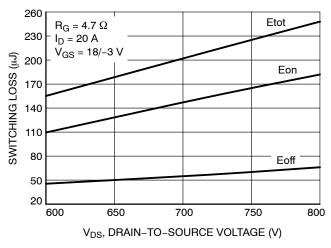


Figure 7. Switching Loss vs. Drain-to-Source Voltage

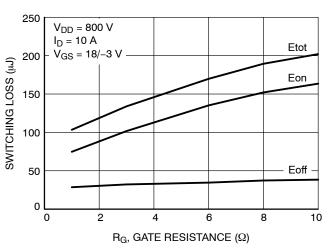


Figure 8. Switching Loss vs. Gate Resistance

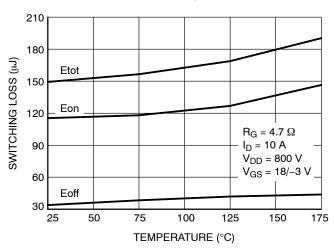


Figure 9. Switching Loss vs. Temperature

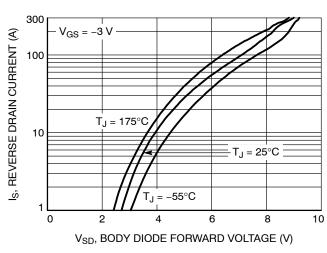


Figure 10. Reverse Drain Current vs. Body Diode Forward Voltage

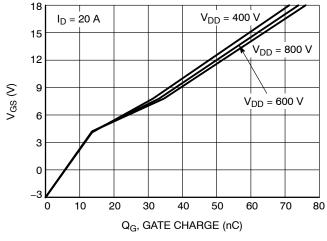


Figure 11. Gate-to-Source Voltage vs. Total Charge

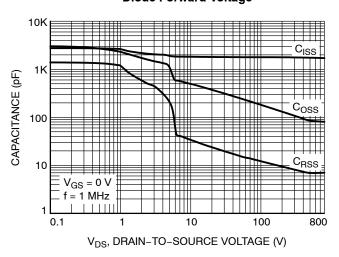


Figure 12. Capacitance vs. Drain-to-Source Voltage

TYPICAL CHARACTERISTICS

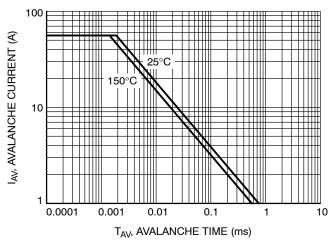


Figure 13. Unclamped Inductive Switching Capability

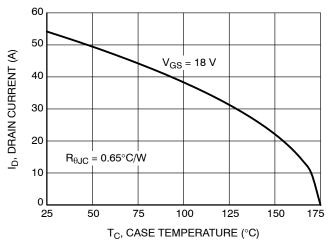


Figure 14. Maximum Continuous Drain Current vs. Case Temperature

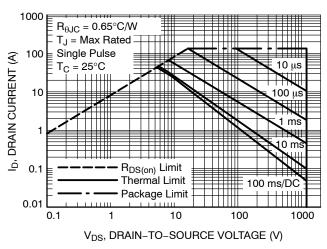


Figure 15. Safe Operating Area

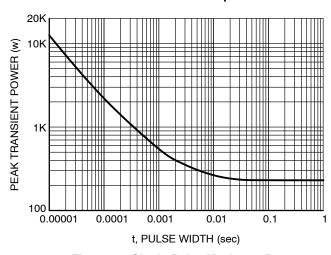


Figure 16. Single Pulse Maximum Power Dissipation

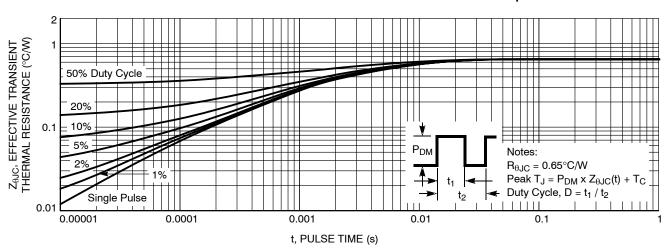


Figure 17. Junction-to-Case Transient Thermal Response

 \emptyset p1

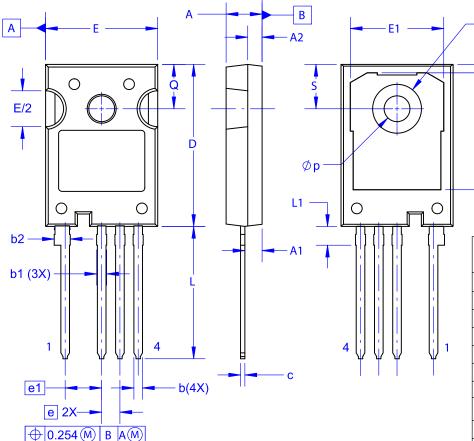
D1

D2



TO-247-4LD CASE 340CJ **ISSUE A**

DATE 16 SEP 2019



NOTES:

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
 B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD
 FLASH, AND TIE BAR EXTRUSIONS.
 C. ALL DIMENSIONS ARE IN MILLIMETERS.
 D. DRAWING CONFORMS TO ASME Y14.5-2009.

| DIM | MILLIMETERS | | | | |
|-----|-------------|----------|-------|--|--|
| DIM | MIN | NOM | MAX | | |
| Α | 4.80 | 5.00 | 5.20 | | |
| A1 | 2.10 | 2.40 | 2.70 | | |
| A2 | 1.80 | 2.00 | 2.20 | | |
| b | 1.07 | 1.20 | 1.33 | | |
| b1 | 1.20 | 1.40 | 1.60 | | |
| b2 | 2.02 | 2.22 | 2.42 | | |
| С | 0.50 | 0.60 | 0.70 | | |
| D | 22.34 | 22.54 | 22.74 | | |
| D1 | 16.00 | 16.25 | 16.50 | | |
| D2 | 0.97 | 1.17 | 1.37 | | |
| е | 2 | 2.54 BSC | | | |
| e1 | 5 | 5.08 BSC | | | |
| E | 15.40 | 15.60 | 15.80 | | |
| E1 | 12.80 | 13.00 | 13.20 | | |
| E/2 | 4.80 | 5.00 | 5.20 | | |
| L | 18.22 | 18.42 | 18.62 | | |
| L1 | 2.42 | 2.62 | 2.82 | | |
| р | 3.40 | 3.60 | 3.80 | | |
| p1 | 6.60 | 6.80 | 7.00 | | |
| Q | 5.97 | 6.17 | 6.37 | | |
| S | 5.97 | 6.17 | 6.37 | | |

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